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Application/Control No. Applicant(s)/Patent Under Reexamination 10/824,094 THOMAS ET AL. Notice of References Cited -Examiner Art Unit Page 2 of 2 Sharidan Carrillo 1746 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2003/0204119 Α 10-2003 Corr et al. 570/179 US-2003/0102007 06-2003 Kaiser, Robert В 134/1 US-С US-Q ŲS-Ε US-F G US-US-Н US-1 US-J US-Κ US-L US- · М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) W Х

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